

Lonten N-channel 650V, 3A, 1.6Ω LonFET™ Power MOSFET

Description

LonFETTM Power MOSFET is fabricated using **advanced super junction** technology. The resulting device has extremely low on resistance, making it especially suitable for applications which require superior power density and outstanding efficiency.

Features

- ◆ Ultra low R_{DS(on)}
- ◆ Ultra low gate charge (typ. Q_g = 7.1nC)
- ◆ 100% UIS tested
- RoHS compliant

Applications

- Power factor correction (PFC).
- Switched mode power supplies (SMPS).
- Uninterruptible power supply (UPS).

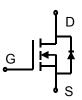
Product Summary

 $\begin{array}{lll} V_{DS} \textcircled{@} T_{j,max} & 700V \\ R_{DS(on),max} & 1.6\Omega \\ I_{DM} & 9A \\ Q_{g,typ} & 7.1nC \end{array}$

Pin Configuration



TO-252





N-Channel MOSFET

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	650	V
Continuous drain current (T _C = 25°C)	ID	3	A
(T _C = 100°C)		1.9	A
Pulsed drain current 1)	I _{DM}	9	A
Gate-Source voltage	V _{GSS}	±30	V
Avalanche energy, single pulse 2)	Eas	67.5	mJ
Power Dissipation	P _D	48	W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C
Continuous diode forward current	Is	3	A
Diode pulse current	I _{S,pulse}	9	A

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	2.6	°C/W
Thermal Resistance, Junction-to-Ambient 3)	R _{0JA}	130	°C/W

Package Marking and Ordering Information

Device	Device Package	Marking	Units/Reel	
LSG65R1K6GT	TO-252	LSG65R1K6GT	2500	



Electrical Characteristics T_c = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Static characteristics	<u>'</u>		,			
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0 V, I _D =0.25 mA	650	-	-	V
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =0.25mA	2.5	3.5	4.5	V
Drain cut-off current	I _{DSS}	V _{DS} =650 V, V _{GS} =0 V,T _j = 25°C	-	-	1	μΑ
Gate leakage current, Forward	I _{GSSF}	V _{GS} =30 V, V _{DS} =0 V	-	-	100	nA
Gate leakage current, Reverse	I _{GSSR}	V _{GS} =-30 V, V _{DS} =0 V	-	-	-100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =1.5A	-			
		T _j = 25°C	-	1.35	1.6	Ω
		T _j = 150°C	-	3.1	-	
Gate resistance	R _G	f=1 MHz, open drain	-	12	-	Ω
Dynamic characteristics						
Input capacitance	C _{iss}	V _{DS} = 100 V, V _{GS} = 0 V,	-	240	-	
Output capacitance	Coss	f = 250 kHz	-	11.3	-	pF
Reverse transfer capacitance	C _{rss}		-	0.75	-	
Turn-on delay time	t _{d(on)}	V _{DD} = 400V, I _D = 1.5A	-	12.4	-	
Rise time	tr	$R_G = 10\Omega$, $V_{GS}=10V$	-	31	-	ns
Turn-off delay time	t _{d(off)}		-	19.6	-	
Fall time	t _f		-	37.6	-	
Gate charge characteristics			•	-		
Gate to source charge	Qgs	V _{DD} =520 V, I _D =1.5A,	-	1.2	-	
Gate to drain charge	Q _{gd}	V _{GS} =0 to 10 V	-	3.2	-	nC
Gate charge total	Qg		-	7.1	-	
Gate plateau voltage	V _{plateau}		-	4.2	-	V
Reverse diode characteristics						
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =3A	-	-	1.1	V
Reverse recovery time	t _{rr}	V _R =400 V, I _F =1.5A,	-	149	-	ns
Reverse recovery charge	Qrr	dI _F /dt=100 A/μs	-	0.68	-	μC
Peak reverse recovery current	Irrm		-	9	-	Α

Notes:

- 1. Limited by maximum junction temperature, maximum duty cycle is 0.75.
- 2. I_{AS} = 1.5A, L=60mH, V_{DD} = 60V, Starting T_j = 25°C.
- 3. The value of R_{thJA} is measured by placing the device in a still air box which is one cubic foot.



Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

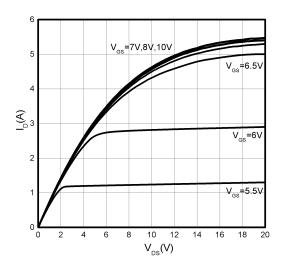


Figure 3. On-Resistance vs. Drain Current

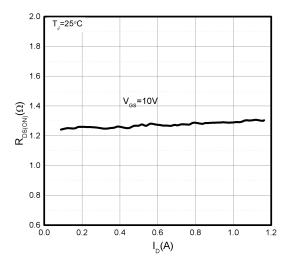


Figure 5.Breakdown Voltage vs.Temperature

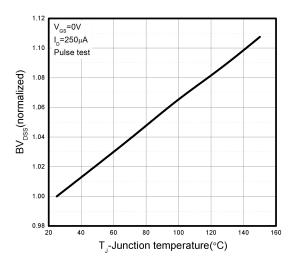


Figure 2. Transfer Characteristics

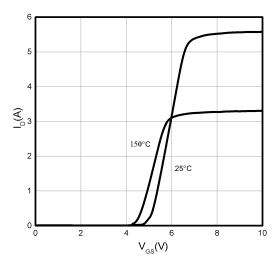


Figure 4.On-Resistance vs.Temperature

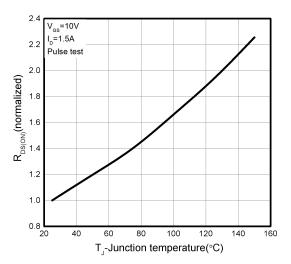


Figure 6.Threshold Voltage vs.Temperature

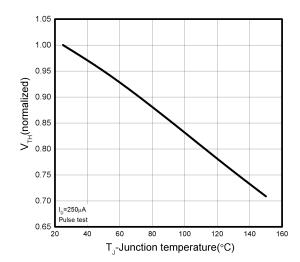




Figure 7.Body-Diode Characteristics

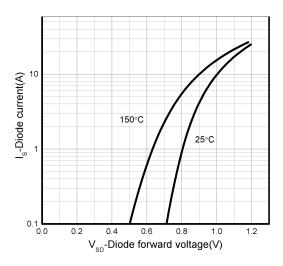


Figure 9.Gate Charge Characteristics

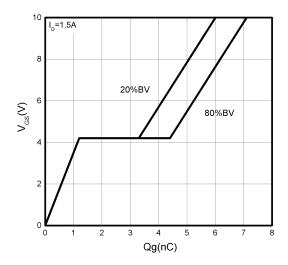


Figure 11. Power Dissipation vs. Temperature

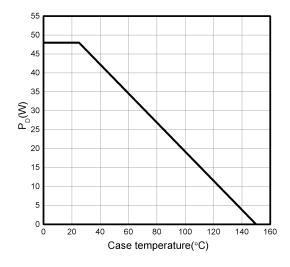


Figure 8. Capacitance Characteristics

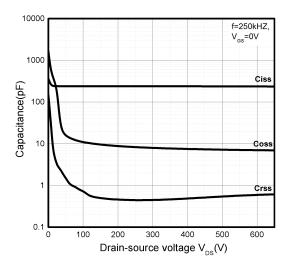


Figure 10.Drain Current Derating

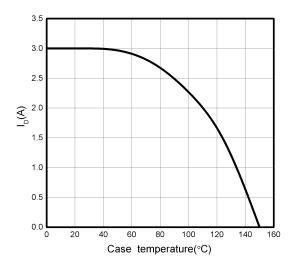


Figure 12: Safe Operating Area

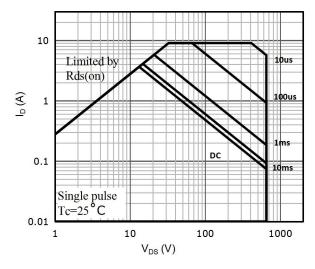
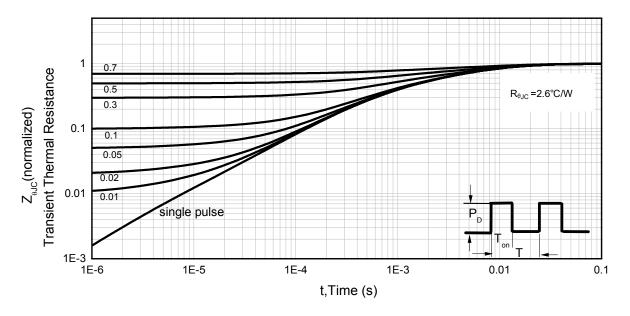




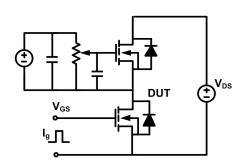
Figure 13. Normalized Maximum Transient Thermal Impedance (RthJC)

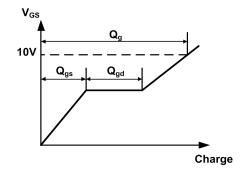




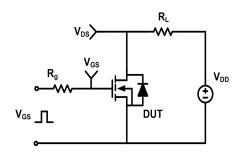
Test Circuit & Waveforms

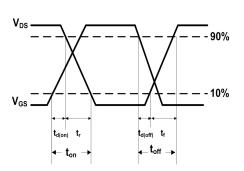
Gate Charge Test Circuit & Waveform



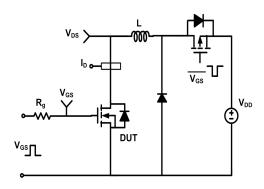


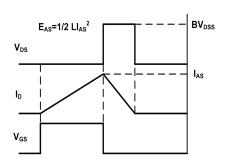
Resistive Switching Test Circuit & Waveform



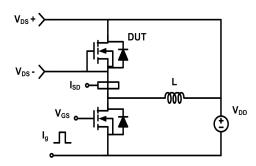


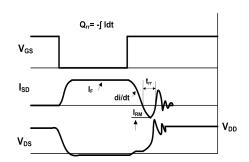
Unclamped Inductive Switching (UIS) Test Circuit & Waveform





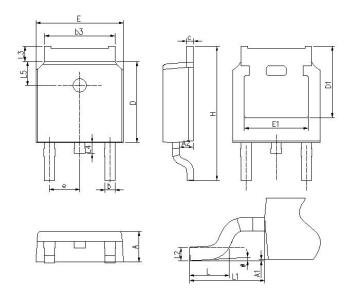
Diode Recovery Test Circuit & Waveform







Mechanical Dimensions for TO-252



DIMENSIONS IN MILLITMETERS			
SYMBOL	MIN	MAX	
A	2. 18	2.4	
A1	_	0.2	
A2	0. 9	1. 17	
b	0.65	0.9	
b3	4. 95	5. 5	
С	0. 43	0.89	
D	5. 97	6. 22	
D1	5. 21	_	
Е	6. 35	6.8	
E1	4. 32	_	
е	2. 286BSC		
Н	9.4	10.5	
L	0.38	1. 78	
L1	2. 90BSC		
L2	0. 51BSC		
L3	0.88	1. 28	
L4		1.02	
L5	1.65	1. 95	
θ	0°	10°	



Version Information

LSG65R1K6GT

Revision:2022-06-01,Rev 1.0

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